



CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P. O. Box 1450, Alexandria, VA 22313-1450 on March 17, 2006

By: Ruth Montalvo / Ruth Montalvo
Customer No. 026418

Date: 03/17/06

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Docket No. JG-SU-5198/500577.20056

Applicant(s): Jun FURUKAWA

Serial No.: 10/784,411

Group: 1722

Filed: February 23, 2004

Examiner: Robert M. Kunemund

For: METHOD OF IDENTIFYING DEFECT DISTRIBUTION IN SILICON SINGLE CRYSTAL
INGOT

Commissioner for Patents
P. O. Box 1450
Alexandria, VA 22313-1450

STATUS REQUEST

Sir,

Please advise the status of the above-identified application and when we can expect to receive an official communication.

Please direct all future telephone calls to:

Jules E. Goldberg, Esq.
(212) 521-5403
at
REED SMITH LLP
599 Lexington Avenue (29th Floor)
New York, NY 10022-7650

Respectfully submitted,

By:

Jules E. Goldberg -- Reg. No. 24,408

March 17, 2006
JEG:ram